

FORM EKC-1449 If AFTER the later date of the first Office Action or 3 months from filing, use only with Rule 97(E) Certificate or Fee INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use several sheets if necessary)</i>		Atty. Docket No. 87804RLO Customer No. 01333		Serial No. 10/822,517	
		Applicant: Yuan-Sheng Tyan, et al			
		Filing Date 12 April 2004		Group 2882	

U.S. PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)	
TA	<i>Yagliioglu et al.; Crystallization of amorphous In_2O_3-10 wt % ZnO thin films annealed in air; 2005; Applied Physics Letters 86, 261908 (2005), col. 1, lines 11-16</i>
TA	<i>Kitamura et al.; Improved Light Outcoupling In Organic Electroluminescent Devices With Random Dots; Japanese Journal of Applied Physics; Vol. 44, No. 1B, 2005, pp. 613, col. 2, lines 14-16.</i>
TA	<i>Chen, A Modified Transparent Conducting Oxide for Flat Panel Displays Only, Jpn. J. Appl. Phys. Vol. 40 (2001), page 1285, Table 1</i>
TA	<i>Jung et al.; Influence Of DC Magnetron Sputtering Parameters On The Properties Of Amorphous Indium Zinc Oxide Thin Film; Thin Solid Films 445 (2003) pp. 63-71.</i>

EXAMINER	/Thomas Artman/	DATE CONSIDERED	09/14/2006
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*EXAMINER: Initial, if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.